# JJMICROELECTRONICS

## 40V, 342A, 0.7m $\Omega$ N-channel Power SGT MOSFET

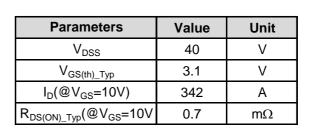
### JMSH040SPGQ

#### Features

- Ultra-low ON-resistance,  $R_{DS(ON)}$
- Low Gate Charge
- 100% UIS Tested
- 100% ΔVds Tested
- Halogen-free; RoHS-compliant
- AEC-Q101 Qualified

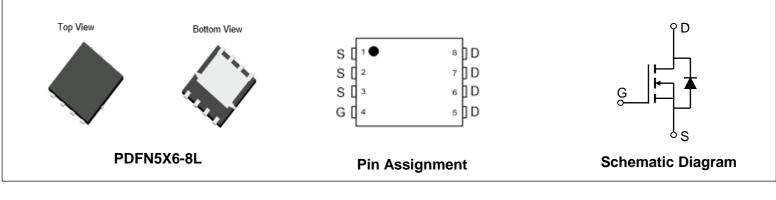
#### Applications

- Load Switch
- PWM Application
- General Automtoive Application



**Product Summary** 





#### **Ordering Information**

Device	Marking	MSL	Form	Package	Reel(pcs)	Per Carton (pcs)
JMSH040SPGQ-13	H040SPQ	1	Tape&Reel	PDFN5x6-8L	5000	50000

#### Absolute Maximum Ratings (@ T<sub>c</sub> = 25°C unless otherwise specified)

Symbol	Parameter		Value	Unit
V <sub>DS</sub>	Drain-to-Source Voltage		40	V
$V_{GS}$	Gate-to-Source Voltage		±20	V
Ι <sub>D</sub>	Continuous Drain Current	$T_C = 25^{\circ}C$	342	Α
		$T_{\rm C} = 100^{\circ}{\rm C}$	242	A
I <sub>DM</sub>	Pulsed Drain Current <sup>(1)</sup>		Refer to Fig.4	A
E <sub>AS</sub>	Single Pulsed Avalanche Energy <sup>(2)</sup>		880	mJ
P <sub>D</sub>	Power Dissipation	$T_C = 25^{\circ}C$	183	W
		$T_{\rm C} = 100^{\circ}{\rm C}$	91	VV
T <sub>J</sub> , T <sub>STG</sub>	Junction & Storage Temperature Range		-55 to 175	°C

#### **Thermal Characteristics**

Symbol	Parameter	Мах	Unit	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient <sup>(3)</sup>	43	°C/W	
$R_{\theta JC}$	Thermal Resistance, Junction to Case	0.8	C/ VV	

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Off Cha	aracteristics					
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	$I_{D} = 250 \mu A, V_{GS} = 0V$	40	-	-	V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = 32V, V_{GS} = 0V$	-	-	1.0	μA
I <sub>GSS</sub>	Gate-Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	-	-	±100	nA
On Cha	racteristics					
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	2.1	3.1	4.0	V
R <sub>DS(ON)</sub>	Static Drain-Source ON-Resistance <sup>(4)</sup>	$V_{GS} = 10V, I_{D} = 20A$	-	0.7	0.9	mΩ
Dynami	ic Characteristics					
$R_g$	Gate Resistance	f = 1MHz	-	1.4	-	Ω
C <sub>iss</sub>	Input Capacitance		4871	6820	9206	pF
C <sub>oss</sub>	Output Capacitance	$V_{GS} = 0V, V_{DS} = 20V,$ f = 1MHz	2793	3910	5278	pF
C <sub>rss</sub>	Reverse Transfer Capacitance		155	217	293	pF
Qg	Total Gate Charge		71	99	134	nC
Q <sub>gs</sub>	Gate Source Charge	$V_{GS} = 0 \text{ to } 10V$ $V_{DS} = 20V, I_D = 20A$	21	30	41	nC
$Q_{gd}$	Gate Drain("Miller") Charge	VDS = 200, 10 = 200	17	24	33	nC
Switchi	ing Characteristics					
t <sub>d(on)</sub>	Turn-On DelayTime		-	23	-	ns
t <sub>r</sub>	Turn-On Rise Time	V <sub>GS</sub> = 10V, V <sub>DD</sub> = 20V	-	33	-	ns
t <sub>d(off)</sub>	Turn-Off DelayTime	$I_D = 20A, R_{GEN} = 3\Omega$	-	54	-	ns
t <sub>f</sub>	Turn-Off Fall Time		-	25	-	ns
Body D	iode Characteristics			•		•
I <sub>S</sub>	Maximum Continuous Body Diode Forward Current		-	-	342	А
$I_{SM}$	Maximum Pulsed Body Diode Forward Current		-	-	1370	А
$V_{\rm SD}$	Body Diode Forward Voltage	$V_{GS} = 0V, I_{S} = 20A$	-		1.2	V
trr	Body Diode Reverse Recovery Time	1 - 150 di/dt = 1000 / tra	54	76	103	ns
Qrr	Body Diode Reverse Recovery Charge	I <sub>F</sub> = 15A, di/dt = 100A/us	-	144	-	nC

#### **Electrical Characteristics** ( $T_J = 25^{\circ}C$ unless otherwise specified)

Notes: 1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.

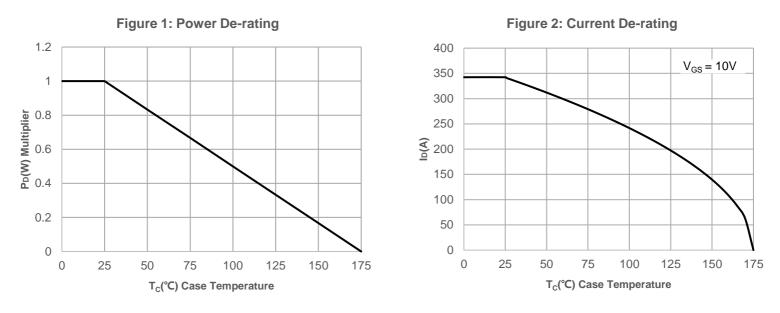
2.  $E_{AS}$  condition: Starting  $T_J$ =25C,  $V_{DD}$ =20V,  $V_G$ =10V,  $R_G$ =25ohm, L=3mH,  $I_{AS}$ =24.22A,  $V_{DD}$ =0V during time in avalanche.

3.  $R_{\theta JA}$  is measured with the device mounted on a 1inch<sup>2</sup> pad of 2oz copper FR4 PCB.

4. Pulse Test: Pulse Width  ${\leqslant}300\mu\text{s},$  Duty Cycle  ${\leqslant}0.5\%.$ 

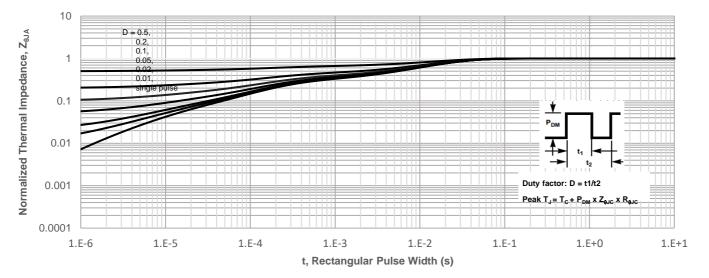




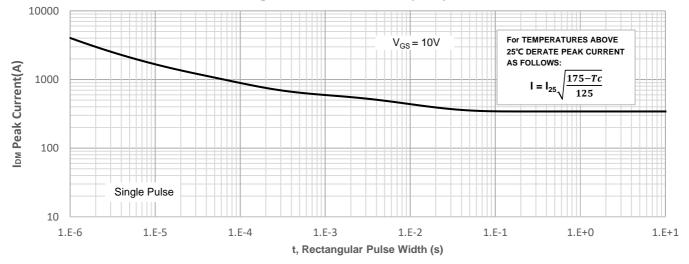


## **Typical Performance Characteristics**







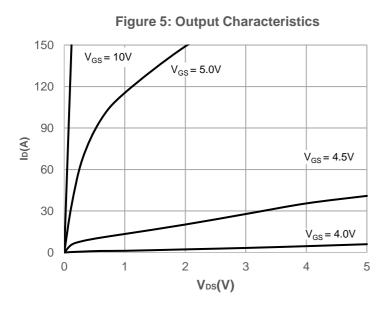


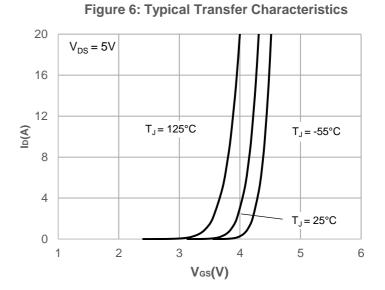
T<sub>J</sub> = -55°C

1

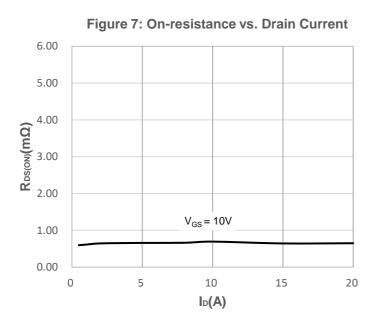
1.2



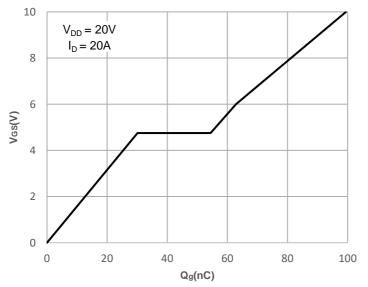




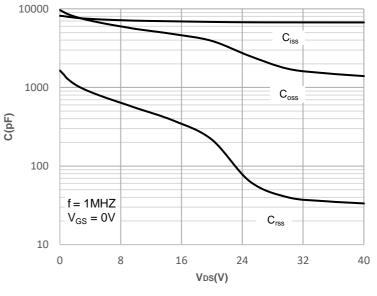
**Figure 8: Body Diode Characteristics** 



**Figure 9: Gate Charge Characteristics** 



**Figure 10: Capacitance Characteristics** 



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0.01 0 0.2 0.4 0.6 0.8 Vsd(V) 10000

= 25

100

10

1

0.1

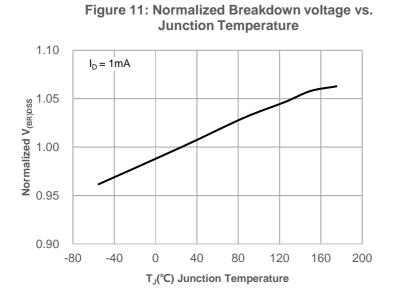
Is(A)

 $V_{GS} = 0V$ 

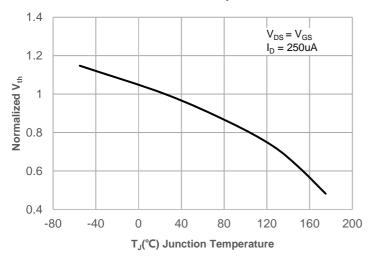
T<sub>J</sub> = 125°C



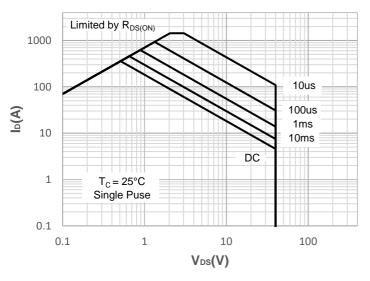
## **Typical Performance Characteristics**







#### Figure 15: Maximum Safe Operating Area



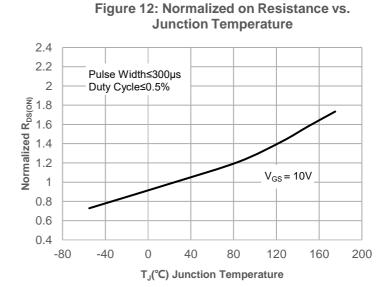
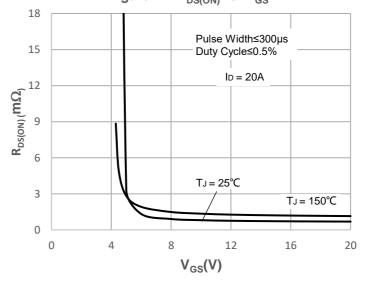


Figure 14: R<sub>DS(ON)</sub> vs. V<sub>GS</sub>



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## **Test Circuit**

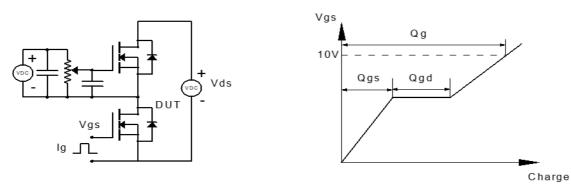


Figure 1: Gate Charge Test Circuit & Waveform

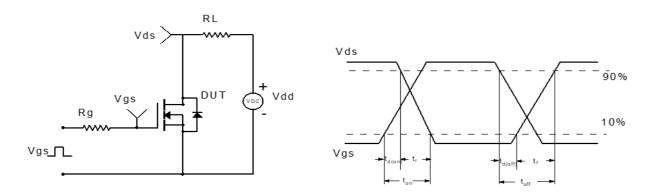


Figure 2: Resistive Switching Test Circuit & Waveform

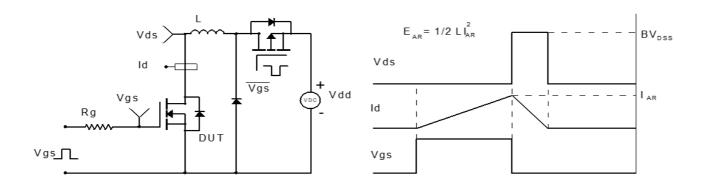


Figure 3: Unclamped Inductive Switching Test Circuit& Waveform

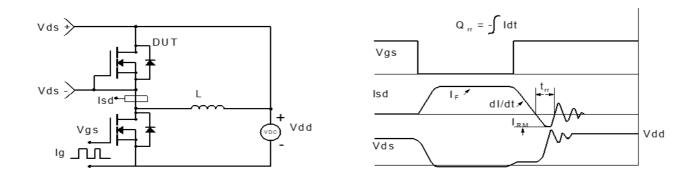


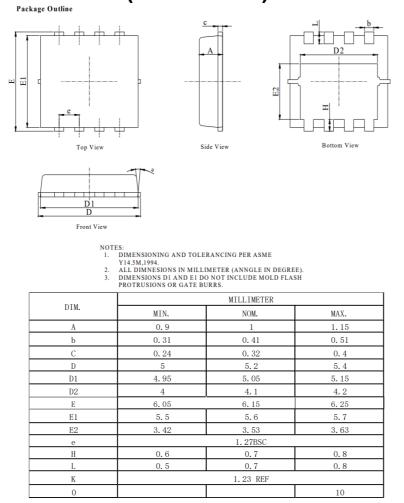
Figure 4: Diode Recovery Test Circuit & Waveform

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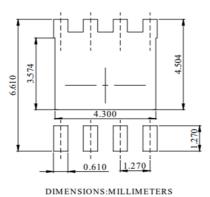
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## Package Mechanical Data(PDFN5X6-8L)



**Recommended Soldering Footprint** 



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